Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/930,672	SCHAAR ET AL.
Examiner	Art Unit
Allen Wong	2621

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	240.2	4/6/2006	AW
375	240	4/6/2006	AW
375	240.01	4/6/2006	AW
375	240.02	4/6/2006	AW
375	240.12	4/6/2006	AW

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
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